

Photoluminescence characteristics of $\text{SiO}_2\text{-GeO}_2\text{-R}_2\text{O}$ (R: Na, K, Rb, and Cs) glasses

Taro Asahi (Faculty of Fundamental Science, National Institute of Technology (KOSEN), Niihama College, t.asahi@niihama-nct.ac.jp, Japan)

Noriyuki Wada (Department of Materials Science and Engineering, KOSEN, Suzuka College, n.wada@szuka-nct.ac.jp, Japan)

Susumu Nakayama (Department of Applied Chemistry and Biotechnology, KOSEN, Niihama College, s.nakayama@niihama-nct.ac.jp, Japan)

Abstract

This study fabricates $50\text{SiO}_2\text{-}50\text{GeO}_2$ and $50\text{SiO}_2\text{-(}50\text{-}x\text{)GeO}_2\text{-}x\text{R}_2\text{O}$ (R: Na, K, Rb, and Cs, $x = 5\text{--}40$) glasses using the conventional melt-quenching method. Their photoluminescence characteristics were investigated by measuring their emission and excitation spectra. In the case of the $50\text{SiO}_2\text{-}50\text{GeO}_2$ glass, a sharp and significant emission band attributed to the Ge^{2+} center appeared prominently at a central wavelength of 395 nm, corresponding to an excitation band at 250 nm. However, the emission spectra of $50\text{SiO}_2\text{-(}50\text{-}x\text{)GeO}_2\text{-}x\text{R}_2\text{O}$ glasses revealed distinct emission bands around 480 and 540 nm, which differ from the 395 nm emission band typically associated with the Ge^{2+} center. These emission bands indicated coordination of the Ge^{2+} center with alkali ions. The basicity of alkali oxide, which is linked to its ability to provide O^{2-} ions, influenced the coordination of the Ge^{2+} center with alkali ions in the glasses, resulting in a decrease in the amount of coordination. Consequently, the intensity of the emission bands varied depending on the quantity and type of alkali components present.

Key words

network modifier oxide, non-bridging oxygen, oxygen vacancy, alkali ions, basicity

1. Introduction

Photoluminescent glass is typically produced by incorporating an activation agent, such as rare earth and transition elements, into the glass matrix during the melting process (Guo et al., 2016; Hwang et al., 2022; Mawlud et al., 2024). Various defects exist in the germanate glass matrix, including the germanium electron trapped center, germanium E' center, neutral oxygen monovacancy, Ge^{2+} center (natural oxygen divacancy), self-trapped hole center, non-bridging oxygen hole center (Ge-O^\cdot), and peroxy radical. Notably, the Ge^{2+} center exhibits dual emission bands centered at 300 and 395 nm, corresponding to excitation bands at 250 and 330 nm (Skujia, 1989; Nishii, 1998). Studies have shown that the emission and excitation bands ascribed to the Ge^{2+} center species shift with the addition of alkali and alkaline earth oxides (Trukhin, 2009; Teng et al., 2010). Furthermore, the intensity of the emission band attributed to the Ge^{2+} center at 399 nm decreases with increasing amounts of alkali and alkaline earth oxides in germanate glasses (Wada, 2006). Apart from the Ge^{2+} center, various defects in oxide glass can lead to optical absorption, distinct from the effects of the activation agent (Skujia et al., 2000; Trukhin and Golant, 2007; Trukhin, 2009). Additionally, adjusting the absorption energy towards the activation agent can potentially develop high-power fluorescent glass.

A previous study demonstrated that the near-white luminescence phenomenon was observed in glasses containing $50\text{SiO}_2\text{-(}50\text{-}x\text{)GeO}_2\text{-}x\text{Na}_2\text{O}$ upon the addition of alkali oxide to $50\text{SiO}_2\text{-}50\text{GeO}_2$ glasses (Nakayama et al., 2017; Asahi et al., 2017). In the present study, we synthesized $50\text{SiO}_2\text{-(}50\text{-}x\text{)}$

$\text{GeO}_2\text{-}x\text{R}_2\text{O}$ glasses (R: Na, K, Rb, and Cs, $x = 5\text{--}40$) and investigated the relationship between fluorescence properties and glass composition through their emission and excitation spectra.

2. Experimental

Germanosilicate and alkali germanosilicate glasses were prepared using the conventional melt-quenching method. The reagents, GeO_2 (Kojundo Chemical Laboratory Co., 99.99 %), SiO_2 (Fujifilm Wako Pure Chemical Co., 99.9 %), and R_2CO_3 (R: Na, K, Rb, and Cs: Fujifilm Wako Pure Chemical Co., Special Grade), were utilized as starting materials. They were weighed to the desired glass batch composition and mixed. The resulting powder mixture was placed into a Pt-13%Rh crucible with a lid and melted in an electric furnace at 1500 °C in an air atmosphere. After melting for 1 h, the crucible was removed and cooled by blowing air with a hairdryer to solidify the glass melt. The obtained samples were ground using a zirconium mortar and subjected to X-ray diffraction (XRD) measurements (Rigaku Co., MiniFlex II) to confirm vitrification. X-ray photoelectron spectroscopy (XPS) measurements of the $\text{Gd}3d$ electronic state were conducted using a PHI5000 VersaProb system (ULvac-phi Inc.) equipped with a monochromatized Al-K α X-ray source ($h\nu = 1486.6$ eV). A spot diameter of 100 μm was considered for the analysis, and the resulting binding energies were calibrated by setting the C 1s peak (C-C bond) to 284.8 eV. Finally, the emission and excitation spectra were recorded using a fluorescence spectrometer (Shimadzu Co., RF-6000) employing a 150-W ozone-free Xenon lamp at a scan rate of 500 nm min^{-1} and step size of 0.1 nm.

3. Results and discussion

3.1 XRD analysis

The XRD spectra of the samples prepared for $50\text{SiO}_2\cdot(50-x)\text{GeO}_2\cdot x\text{Na}_2\text{O}$ ($x = 5-40$) and $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{R}_2\text{O}$ (R: Na, K, Rb, and Cs) are depicted in Figure 1. Small diffraction peaks corresponding to the $\text{Na}_2\text{Si}_2\text{O}_5$ (ICDD No. 23-529) and Na_2SiO_3 (ICDD No. 16-818) phases were observed in the $50\text{SiO}_2\cdot(50-x)\text{GeO}_2\cdot x\text{Na}_2\text{O}$ ($x = 5-40$) series XRD pattern for $x = 40$. For $x = 5-35$, the $50\text{SiO}_2\cdot(50-x)\text{GeO}_2\cdot x\text{Na}_2\text{O}$ ($x = 5-40$) and $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{R}_2\text{O}$ (R: Na, K, Rb, and Cs) series revealed only a halo-like XRD pattern, which confirms that these samples did undergo vitrification. All the prepared $50\text{SiO}_2\cdot(50-x)\text{GeO}_2\cdot x\text{Na}_2\text{O}$ ($x = 5-40$) and $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{R}_2\text{O}$ (R: Na, K, Rb, and Cs) samples appeared transparent. The $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{Li}_2\text{O}$ sample did not vitrify using the preparation method reported herein; instead, it underwent crystallization.

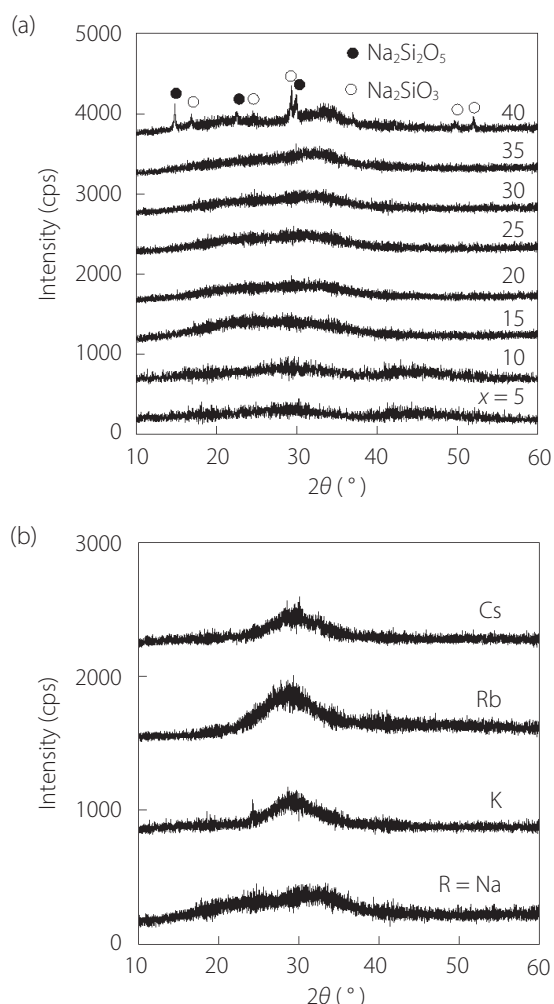


Figure 1: XRD patterns of (a) $50\text{SiO}_2\cdot(50-x)\text{GeO}_2\cdot x\text{Na}_2\text{O}$ ($x = 5-40$) and (b) $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{R}_2\text{O}$ (R: Na, K, Rb, and Cs) samples

Note: Closed and open circles denote $\text{Na}_2\text{Si}_2\text{O}_5$ and Na_2SiO_3 phases, respectively.

3.2 XPS analysis

The $\text{Ge}3d$ XPS spectra of the $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{Na}_2\text{O}$ and $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{K}_2\text{O}$ glasses are shown in Figure 2 (a) and (b), respectively. Peaks corresponding to the $\text{Ge}3d$ state were detected at 30.96 and 33.22 eV for the $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{Na}_2\text{O}$ glass, as determined by peak deconvolution (Asahi et al., 2017). Moreover, peaks corresponding to the $\text{Ge}3d$ state were detected at 31.37 and 32.73 eV for the $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{K}_2\text{O}$ glass. Wang et al. reported $\text{Ge}-\text{O}$ peaks corresponding to the chemical species $\text{Ge}_3\equiv\text{Ge}-\text{O}$ (Ge^{1+}), $\text{Ge}_2=\text{Ge}=\text{O}_2$ (Ge^{2+}), $\text{Ge}-\text{Ge}\equiv\text{O}_3$ (Ge^{3+}), and $\text{O}-\text{Ge}\equiv\text{O}_3$ (Ge^{4+}) at 30.88, 31.78, 32.69, and 33.57 eV, respectively, for $(\text{SiO}_2)_{50}(\text{GeO}_2)_{50}$ (Wang et al., 1998); this indicates that the Ge atoms in the $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{Na}_2\text{O}$ and $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{K}_2\text{O}$ glasses exhibit two distinct valence states (Ge^{2+} and Ge^{4+}). In our study, these two valence states were observed in the $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{Na}_2\text{O}$ and $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{K}_2\text{O}$ glasses at ratios of 13.67/86.33 and 15.42/84.58, respectively, supporting the aforementioned results obtained by Wang et al.

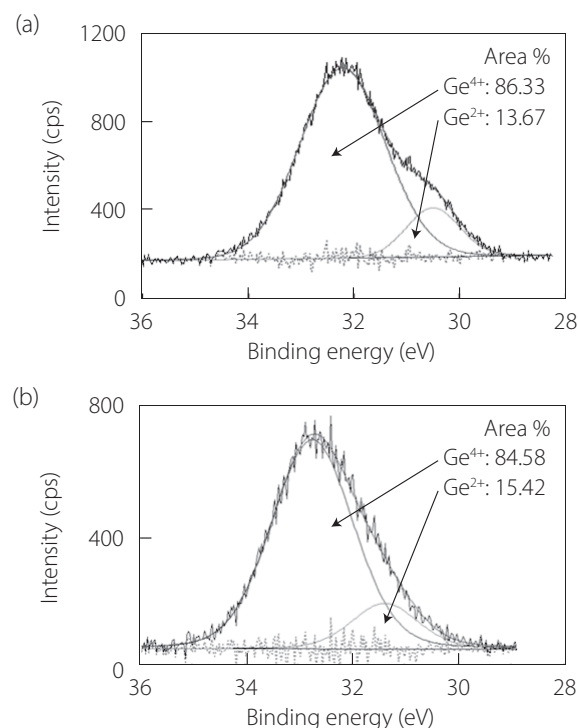


Figure 2: $\text{Ge}3d$ XPS spectra of (a) $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{Na}_2\text{O}$ and (b) $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{K}_2\text{O}$ glasses

3.3 Photoluminescence characteristics

The emission and excitation spectra, along with the excitation–emission matrices, of $50\text{SiO}_2\cdot 50\text{GeO}_2$ and $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{Na}_2\text{O}$ glasses are shown in Figure 3. In the case of $50\text{SiO}_2\cdot 50\text{GeO}_2$, the emission peak occurs at a narrow range of 400 nm, corresponding to excitation at a near short-wavelength ultraviolet region, resulting in a blue emission phenomenon. Conversely, for the $50\text{SiO}_2\cdot 20\text{GeO}_2\cdot 30\text{Na}_2\text{O}$

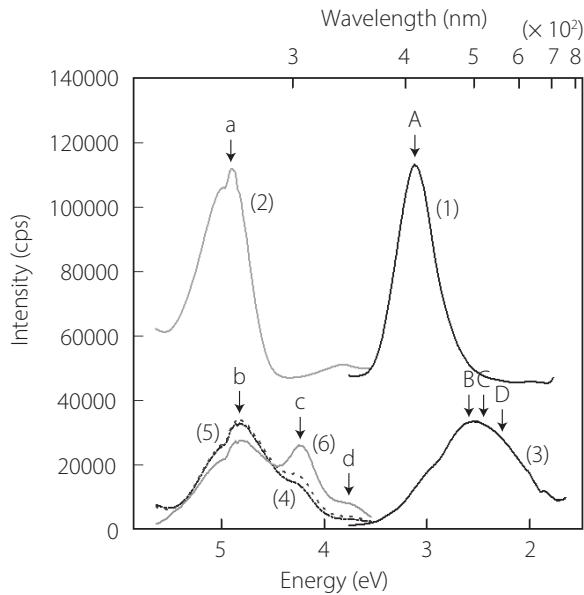


Figure 3: Emission and excitation spectra of 50SiO₂:50GeO₂ and 50SiO₂:20GeO₂:30Na₂O glasses

Note: (1) λ_{em} = 253 nm, (2) λ_{em} = 397 nm, (3) λ_{em} = 258 nm, (4) λ_{em} = 475 nm, (5) λ_{em} = 487 nm, and (6) λ_{em} = 549 nm.

glass, new emission peaks emerged in the range of 500 to 600 nm, corresponding to the near 300 nm excitation range, leading to a near-white emission phenomenon. The fluorescent color coordinates for 50SiO₂:50GeO₂ and 50SiO₂:20GeO₂:30Na₂O were (0.172, 0.059) and (0.283, 0.333), respectively. The substitution of Na₂O for GeO₂ in the 50SiO₂:50GeO₂ series was found to alter the fluorescence characteristics.

Emission (corresponding to (1) in Figure 3) and excitation (corresponding to (2) in Figure 3) spectra of 50SiO₂:50GeO₂ glass included the emission band A and excitation band a at 397 and 253 nm, respectively. These two bands are attributed to the Ge²⁺ center, a defect in the germanate glass. However, in the 50SiO₂:20GeO₂:30Na₂O glass, the emission band B and C appeared at positions 475 and 487 nm without reducing the intensity of the emission band A. Additionally, a new emission band D emerged at 549 nm. Consequently, emission bands B, C, and D contributed to the broadening of the emission spectra (corresponding to (3) in Figure 3). In the excitation spectra (corresponding to (4), (5), and (6) in Figure 3) for the ascribed emission bands B, C, and D, excitation bands at 255, 292, and 330 nm appeared as band b, c, and d, respectively. Thus, in glass samples containing alkali oxide, it was observed that emission bands B, C, and D appeared instead of the emission band A ascribed to the Ge²⁺ center. Additionally, excitation bands b, c, and d appeared instead of the excitation band a. These results indicate that new emission and excitation bands observed in spectra (3), (4), (5), and (6) are attributed to Ge²⁺ center coordinated Na⁺ ions.

Figure 4 illustrates the energy diagram for the Ge²⁺ center

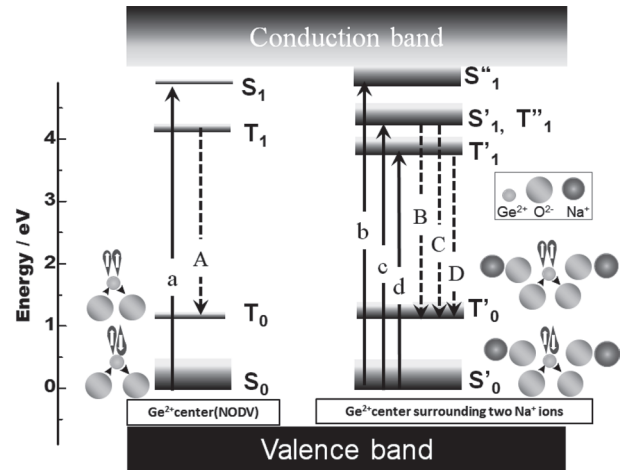


Figure 4: Schematic of the energy level of (a) 50SiO₂:50GeO₂ and (b) 50SiO₂:20GeO₂:30Na₂O glasses

inferred from the emission and excitation spectra shown in Figure 3. Both the emission band at 300 nm and the excitation band at 330 nm were initially unlikely to appear due to forbidden singlet-to-triplet transitions for the Ge²⁺ center, in the 50SiO₂:50GeO₂ glass samples. However, in the 50SiO₂:20GeO₂:30Na₂O glass samples, the forbidden transitions from singlet to triplet were allowed through the coordination with Na⁺ ions, resulting in the observation of excitation bands b, c, and d instead of the excitation band a. The coordination of the Ge²⁺ centers with Na⁺ ions could potentially lead to the splitting of energy levels within a distorted local glass structure, forming multiple energy levels based on the position and orientation of alkali ions in the glass samples. Therefore, it is proposed that the appearance of emission bands B, C, and D reflect transitions between the T₀' energy level and the T₁' and T₁'' ones.

Figure 5 shows emission spectra in the sample of 50SiO₂:(50-x)GeO₂:xNa₂O series. For x up to 30, both emission bands B and C exhibited increased intensity with higher alkali contents. The maximum intensity of emission bands B and C occurs at x = 30. Conversely, for x values exceeding 30, the intensity of bands B and C decreased with higher alkali oxide contents, albeit at different rates. Furthermore, emission bands B and C shifted toward longer wavelengths. These changes are attributed to the distortion of the local structure of the Ge²⁺ center and the gradual disappearance of Ge²⁺ centers with increasing alkali content. The Na₂O component, functioning as a glass network modifier with high basicity, introduces oxide ions (O²⁻) into the glass melt. This addition of oxide ions leads to the formation of non-bridging oxygen, altering the local glass structure from tight to loose, ultimately resulting in the disappearance of Ge²⁺ centers in the glass samples.

The emission spectra of the 50SiO₂:20GeO₂:30R₂O series depicted in Figure 6 show that the spectrum of sodium series (R:

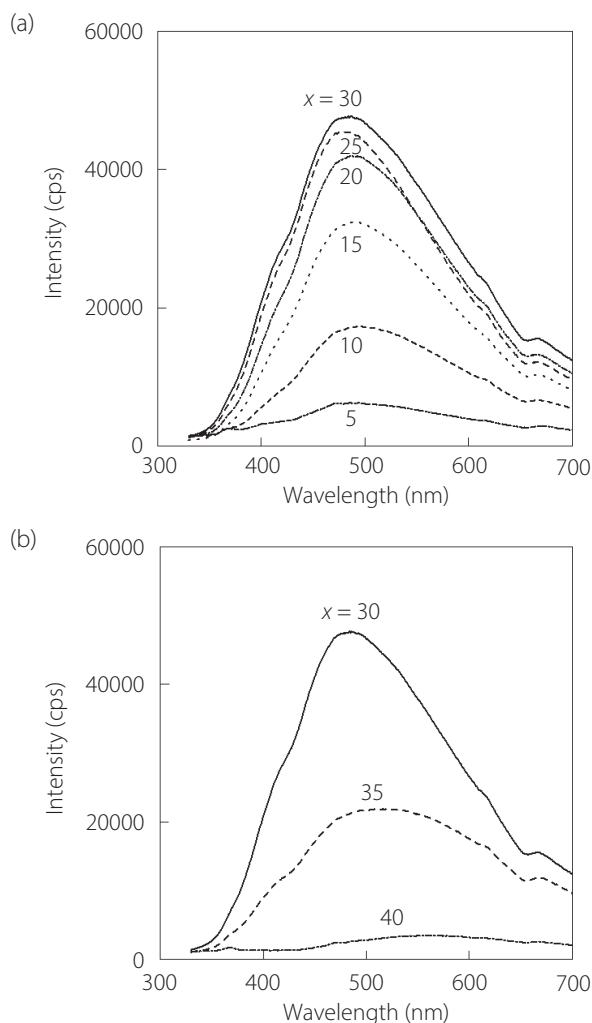


Figure 5: Emission spectra of 50 SiO₂-(50-x) GeO₂-xNa₂O (a): x = 5, 10, 15, 20, and 25, (b): x = 30, 35, and 40) glasses excited at 250 nm

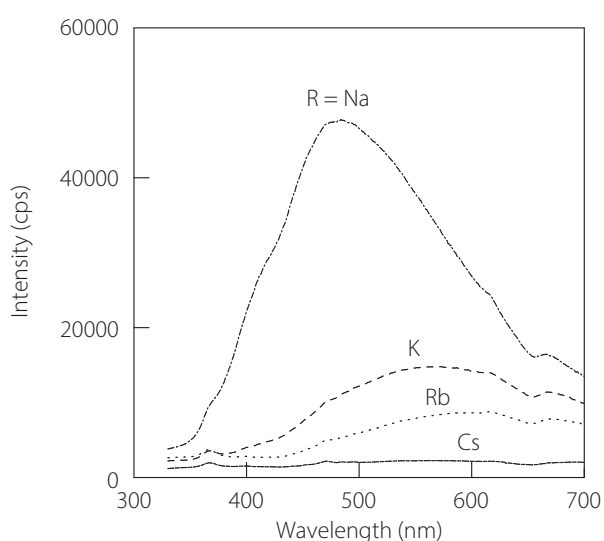


Figure 6: Emission spectra of 50SiO₂-20GeO₂-30R₂O (R: Na, K, Rb, and Cs) glasses excited at 250 nm

Na) exhibits the maximum intensity. The fluorescent color coordinates for 50SiO₂-20GeO₂-30R₂O (R: Na, K, Rb, and Cs) were (0.283, 0.333), (0.369, 0.40), (0.392, 0.403), and (0.346, 0.364), respectively. Emission bands B and C decrease in the following sequence: Na → K → Rb → Cs. The basicity of alkali oxides follows a similar trend: Na₂O → K₂O → Rb₂O → Cs₂O. Alkali and alkaline earth oxides, acting as glass network modifiers with high basicity and large ionic radius, significantly influence the structure of Ge²⁺ centers by providing oxide ions into the glass melt. Consequently, the distortion and dispersion of Ge²⁺ centers in the glass increase accordingly. Moreover, the emission bands B and C, attributed to Ge²⁺ centers coordinated with alkali ions, vary based on the type and quantity of alkali species.

4. Conclusions

In this study, we investigated the photoluminescence characteristics of 50SiO₂-(50-x)GeO₂-xR₂O glass in comparison to 50SiO₂-50GeO₂ glass. In the emission spectrum corresponding to the addition of alkali oxide to 50SiO₂-50GeO₂ glass, in addition to the emission band due to the Ge²⁺ center, new emission bands and excitation bands due to the Ge²⁺ center coordinated with alkali ions are observed. The intensity of these novel emission bands varies with the alkali content, reaching its maximum value at x = 30. Additionally, the intensity of emission bands associated with Ge²⁺ centers coordinated with alkali ions decreases with increasing alkali ion radius. The relationship between the intensity of emission bands and glass compositions is linked to the basicity of alkali oxide. As alkali oxide functions as a glass network modifier, the addition of highly basic alkali oxide provides ample oxide ions to the Ge²⁺ centers in the glass melt. Consequently, the amount of Ge²⁺ centers coordinated with alkali ions decreases in the glass samples, leading to a reduction in the intensity of the corresponding emission bands.

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